

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Application of: Muriel MARTINEZ et al.

Application No.: To be assigned

Group Art Unit:

Filed:

Examiner:

For: SUBSTRATE LAYER CUTTING DEVICE AND METHOD Attorney Docket No.: 4717-4800

**INFORMATION DISCLOSURE STATEMENT**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, Virginia 22313-1450

Sir:

Pursuant to applicants' duty of disclosure under 37 C.F.R. 1.56, enclosed are copies of (7) references for the Examiner's review and consideration. These references are listed on the enclosed Form PTO-1449. A copy of a Search Report in the counterpart International application is also enclosed.

Please note that U.S. Patent No. 6,382,292 is equivalent to EP 0,867,917, and that US 6,427,748 is equivalent to EP 097,242. These European publications are listed on the Search Report submitted herewith.

Pursuant to the recent rule change in the Official Gazette, only copies of the foreign references are enclosed. Copies of the U.S. references are not submitted. It is respectfully requested that these references be made of record in this application by the Examiner's completion and return of the PTO Form 1449.

No fee or certification is believed to be due for this submission since the references are being submitted concurrent with the filing of this application. Should any fees be required, however, please charge such fees to **Winston & Strawn LLP** Deposit Account No. 501-814.

Date: October 7, 2003

Respectfully submitted,



Allan A. Fanucci (Reg. No. 30,256)

**WINSTON & STRAWN LLP**

**CUSTOMER NO. 28765**

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Enclosures

<b>LIST OF REFERENCES CITED BY APPLICANT</b> <b>Form PTO-1449</b> <i>(Use several sheets if necessary)</i>				ATTY. DOCKET NO.:		APPLICATION NO.:		
				4717-4800				
				APPLICANT:				
				Muriel MARTINEZ et al.				
				FILING DATE:		GROUP:		
<b>U.S. PATENT DOCUMENTS</b>								
*EXAMINER INITIAL	CITE NO	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
	AA	5,374,564	12/1994	Bruehl	437	24		
	AB	6,050,255	4/2000	Sievert	125	23.01		
	AC	6,382,292	5/2002	Ohmi et al.	156	584		
	AD	6,418,999	7/2002	Yanagita et al.	156	584		
	AE	6,427,748	8/2002	Yanagita et al.	156	584		
<b>FOREIGN PATENT DOCUMENTS</b>								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
	AF	EP 0 989 593 A2	3/2000	Europe			X	
	AG	WO 01/10644	2/2001	PCT			X	
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)</b>								
<b>EXAMINER</b>				<b>DATE CONSIDERED</b>				
*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								